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10/003375



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## U.S. UTILITY Patent Application

PATENT NUMBER and  
ISSUE DATE

APPL NUM 10003375	FILING DATE 11/15/2001	CLASS 324	SUBCLASS 765.000	GAU 2862	EXAMINER Nguyen, Tung
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**\*\*APPLICANTS:** Ong Adrian; Englekemier Darren; Sprague Edward; Miller Alan;  
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**\*\*CONTINUING DATA VERIFIED:**  
THIS APPLN CLAIMS BENEFIT OF 60/279,416 03/28/2001  
WHICH IS A CON OF 09/384,791 08/26/1999 PAT 6,195,237

**\*\*FOREIGN APPLICATIONS VERIFIED:**  
ITALY MI2000A 002318 10/26/2000

PG-PUB DO NOT PUBLISH <input checked="" type="checkbox"/>	RESCIND <input type="checkbox"/>
Foreign priority claimed <input type="checkbox"/> yes <input type="checkbox"/> no	ATTORNEY DOCKET NO M-9433 US
35 USC 119 conditions met <input type="checkbox"/> yes <input type="checkbox"/> no	
Verified and Acknowledged Examiner's initials	
TITLE: Layout and use of bond pads and probe pads for testing of integrated circuits devices	

U.S. DEPT. OF COM. / PAT. & TM. PTO-1324 Rev. 12-94

<b>NOTICE OF ALLOWANCE MAILED</b>		<b>CLAIMS ALLOWED</b>	
		Total Claims	Print Claim for O.G.
Assistant Examiner			
<b>ISSUE FEE</b>		<b>DRAWING</b>	
Amount Due	Date Paid	Sheets Drwg.	Figs. Drwg.
		Print Fig.	
Primary Examiner		Application Examiner	
<input checked="" type="checkbox"/> <b>TERMINAL</b>		<b>PREPARED FOR ISSUE</b>	
<b>DISCLAIMER</b>		<b>WARNING:</b> The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.	

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